



8NM65

Power MOSFET

8.0A, 650V N-CHANNEL SUPER-JUNCTION MOSFET

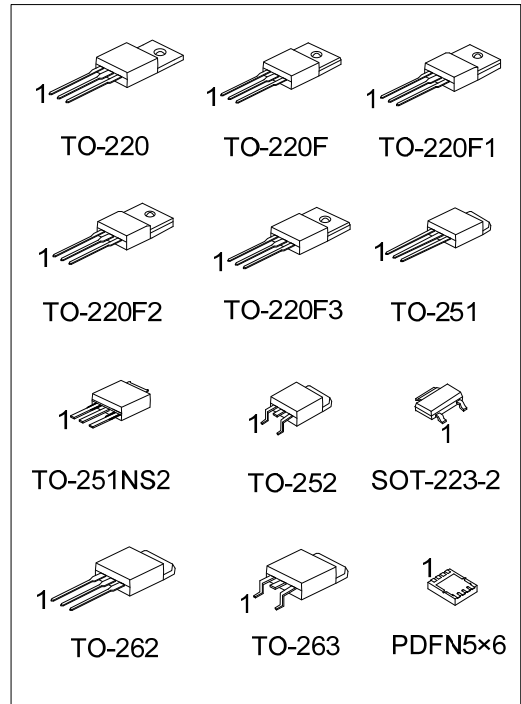
DESCRIPTION

The UTC **8NM65** is a Super Junction MOSFET Structure. It uses UTC advanced planar stripe, DMOS technology to provide customers perfect switching performance, minimal on-state resistance.

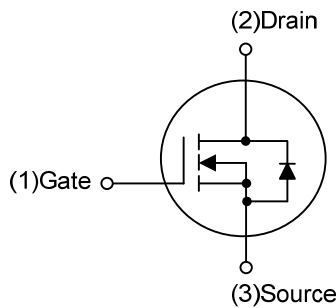
The UTC **8NM65** is universally applied in electronic lamp ballasts based on half bridge topology, high efficiency switched mode power supplies, active power factor correction, etc.

FEATURES

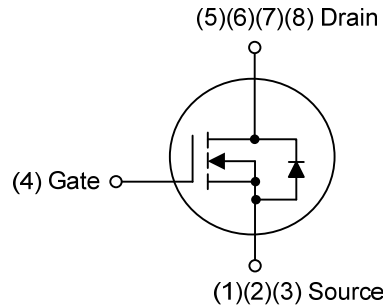
- * $R_{DS(ON)} \leq 0.75 \Omega$ @ $V_{GS}=10V, I_D=4.0A$
- * Fast Switching Capability
- * Avalanche Energy Tested
- * Improved dv/dt Capability, High Ruggedness



SYMBOL



SOT-223-2/TO-220/TO-220F/TO-220F1
 TO-220F2/TO-220F3/TO-251
 TO-251NS2/TO-252/TO-262/TO-263




PDFN5x6

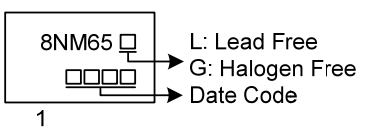
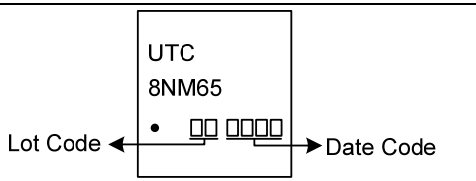
ORDERING INFORMATION

Ordering Number		Package	Pin Assignment								Packing
Lead Free	Halogen Free		1	2	3	4	5	6	7	8	
8NM65L-AA2-R	8NM65G-AA2-R	SOT-223-2	G	D	S	-	-	-	-	-	Tape Reel
8NM65L-TA3-T	8NM65G-TA3-T	TO-220	G	D	S	-	-	-	-	-	Tube
8NM65L-TF1-T	8NM65G-TF1-T	TO-220F1	G	D	S	-	-	-	-	-	Tube
8NM65L-TF2-T	8NM65G-TF2-T	TO-220F2	G	D	S	-	-	-	-	-	Tube
8NM65L-TF3-T	8NM65G-TF3-T	TO-220F	G	D	S	-	-	-	-	-	Tube
8NM65L-TF3T-T	8NM65G-TF3T-T	TO-220F3	G	D	S	-	-	-	-	-	Tube
8NM65L-TM3-T	8NM65G-TM3-T	TO-251	G	D	S	-	-	-	-	-	Tube
8NM65L-TMN2-T	8NM65G-TMN2-T	TO-251NS2	G	D	S	-	-	-	-	-	Tube
8NM65L-TN3-R	8NM65G-TN3-R	TO-252	G	D	S	-	-	-	-	-	Tape Reel
8NM65L-T2Q-T	8NM65G-T2Q-T	TO-262	G	D	S	-	-	-	-	-	Tube
8NM65L-TQ2-T	8NM65G-TQ2-T	TO-263	G	D	S	-	-	-	-	-	Tube
8NM65L-TQ2-R	8NM65G-TQ2-R	TO-263	G	D	S	-	-	-	-	-	Tape Reel
8NM65L-P5060-R	8NM65G-P5060-R	PDFN5×6	S	S	S	G	D	D	D	D	Tape Reel

Note: Pin Assignment: G: Gate D: Drain S: Source

 <p>8NM65G-AA2-R</p> <ul style="list-style-type: none"> (1) Packing Type (2) Package Type (3) Green Package 	<p>(1) R: Tape Reel, T: Tube</p> <p>(2) AA2: SOT-223-2, TA3: TO-220, TF1: TO-220F1, TF2: TO-220F2, TF3: TO-220F, TF3T: TO-220F3, TM3: TO-251, TMN2: TO-251NS2, TN3: TO-252, T2Q: TO-262, TQ2: TO-263, P5060: PDFN5×6</p> <p>(3) G: Halogen Free and Lead Free, L: Lead Free</p>
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MARKING

PACKAGE	MARKING
SOT-223-2	 <p>8NM65 □ □ □ □ □ □</p> <p>1</p> <p>L: Lead Free G: Halogen Free Date Code</p>
TO-220 TO-220F TO-220F1 TO-220F2 TO-220F3	TO-251 TO-251NS2 TO-252 TO-262 TO-263
PDFN5×6	 <p>UTC 8NM65</p> <p>Lot Code ← • □ □ □ □ □ □ → Date Code</p>

■ ABSOLUTE MAXIMUM RATINGS ($T_C = 25^\circ\text{C}$, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V_{DSS}	650	V
Gate-Source Voltage		V_{GSS}	± 30	V
Drain Current	Continuous	I_D	8.0	A
	Pulsed (Note 2)	I_{DM}	32	A
Avalanche Current (Note 2)		I_{AR}	1.9	A
Avalanche Energy	Single Pulsed (Note 3)	E_{AS}	260	mJ
Peak Diode Recovery dv/dt (Note 4)		dv/dt	5.0	V/ns
Power Dissipation	SOT-223-2	P_D	5.5	W
	TO-220/TO-262 TO-263		75	W
	TO-220F/TO-220F1 TO-220F2/TO-220F3		27	W
	TO-251/TO-251NS2 TO-252		50	W
	PDFN5×6		26	W
	Junction Temperature		T_J	+150
Storage Temperature		T_{STG}	-55 ~ +150	$^\circ\text{C}$

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating: Pulse width limited by maximum junction temperature.

3. $L=144\text{mH}$, $I_{AS}=1.9\text{A}$, $V_{DD}=50\text{V}$, $R_G=25\ \Omega$, Starting $T_J = 25^\circ\text{C}$

4. $I_{SD} \leq 8.0\text{A}$, $di/dt \leq 200\text{A}/\mu\text{s}$, $V_{DD} \leq BV_{DSS}$, Starting $T_J = 25^\circ\text{C}$

■ THERMAL DATA

PARAMETER		SYMBOL	RATINGS	UNIT		
Junction to Ambient	SOT-223-2	θ_{JA}	150	$^\circ\text{C/W}$		
	TO-220/TO-220F TO-220F1/TO-220F2 TO-220F3/TO-262 TO-263		62.5	$^\circ\text{C/W}$		
	TO-251/TO-251NS2 TO-252		110	$^\circ\text{C/W}$		
	PDFN5×6		75	$^\circ\text{C/W}$		
	Junction to Case		SOT-223-2	θ_{JC}	22	$^\circ\text{C/W}$
			TO-220/TO-262 TO-263		1.66	$^\circ\text{C/W}$
TO-220F/TO-220F1 TO-220F2/TO-220F3		4.6	$^\circ\text{C/W}$			
TO-251/TO-251NS2 TO-252		2.55	$^\circ\text{C/W}$			
PDFN5×6		4.8	$^\circ\text{C/W}$			

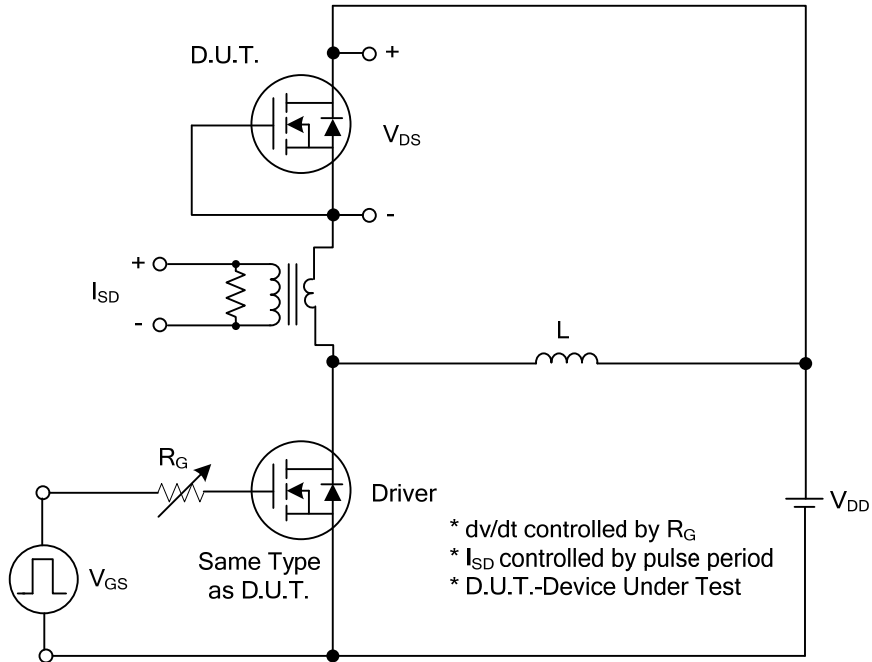
■ ELECTRICAL CHARACTERISTICS ($T_J=25^\circ\text{C}$, unless otherwise specified)

PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage		BV_{DSS}	$V_{GS}=0V, I_D=250\mu A$	650			V
Drain-Source Leakage Current		I_{DSS}	$V_{DS}=650V, V_{GS}=0V$			10	μA
Gate- Source Leakage Current	Forward	I_{GSS}	$V_{GS}=30V, V_{DS}=0V$			100	nA
	Reverse		$V_{GS}=-30V, V_{DS}=0V$			-100	nA
ON CHARACTERISTICS							
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS}=V_{GS}, I_D=250\mu A$	2.5		4.5	V
Static Drain-Source On-State Resistance		$R_{DS(ON)}$	$V_{GS}=10V, I_D=4.0A$		0.57	0.75	Ω
DYNAMIC CHARACTERISTICS							
Input Capacitance		C_{ISS}	$V_{DS}=50V, V_{GS}=0V, f=1.0\text{ MHz}$		330		pF
Output Capacitance		C_{OSS}			248		pF
Reverse Transfer Capacitance		C_{RSS}			3.5		pF
SWITCHING PARAMETERS							
Total Gate Charge (Note 1)		Q_G	$V_{DS}=520V, V_{GS}=10V$ $I_D=8.0A, I_G=1mA$ (Note 1,2)		17		nC
Gate to Source Charge		Q_{GS}			4		nC
Gate to Drain Charge		Q_{GD}			5.5		nC
Turn-on Delay Time (Note 1)		$t_{D(ON)}$	$V_{DD}=100V, V_{GS}=10V, I_D=8.0A,$ $R_G=25\Omega$ (Note 1, 2)		9		ns
Rise Time		t_R			20		ns
Turn-off Delay Time		$t_{D(OFF)}$			58		ns
Fall-Time		t_F			36		ns
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS							
Maximum Body-Diode Pulsed Current		I_S				8	A
Drain-Source Diode Forward Voltage (Note 1)		I_{SM}				32	A
Maximum Body-Diode Continuous Current		V_{SD}	$I_S=8.0A, V_{GS}=0V$			1.4	V
Reverse Recovery Time (Note 1)		t_{rr}	$I_S=8.0A, V_{GS}=0V$		320		ns
Reverse Recovery Charge		Q_{rr}	$di_f/dt=100A/\mu s$		3.6		μC

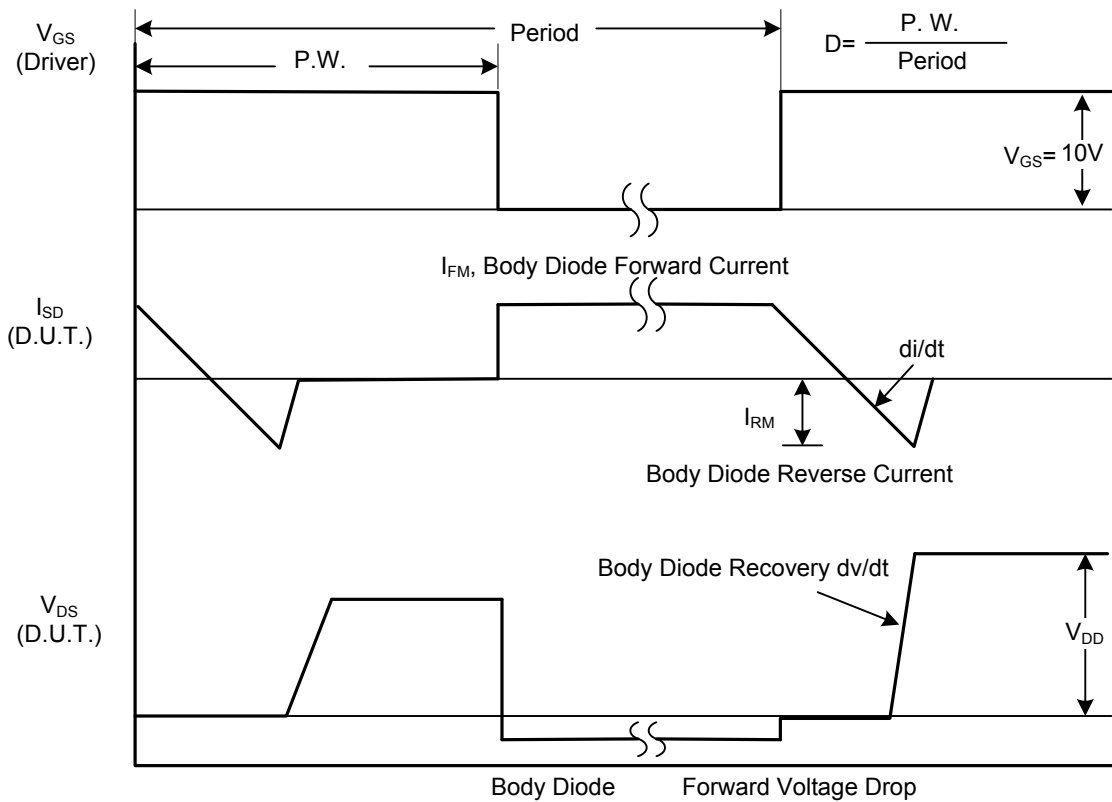
Notes: 1. Pulse Test: Pulse width $\leq 300\mu s$, Duty cycle $\leq 2\%$.

2. Essentially independent of operating temperature.

■ TEST CIRCUITS AND WAVEFORMS

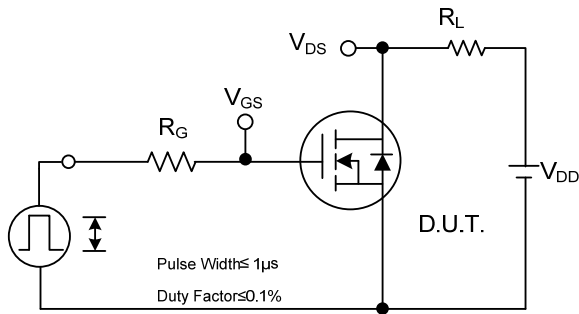


Peak Diode Recovery dv/dt Test Circuit

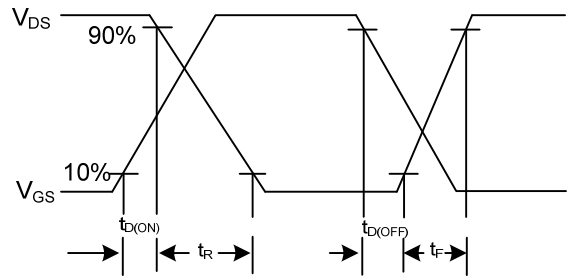


Peak Diode Recovery dv/dt Waveforms

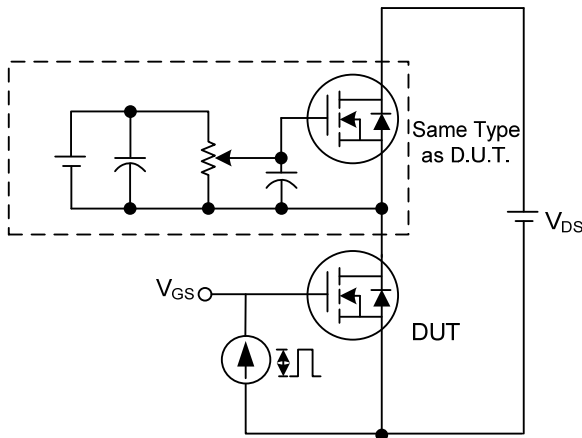
■ TEST CIRCUITS AND WAVEFORMS



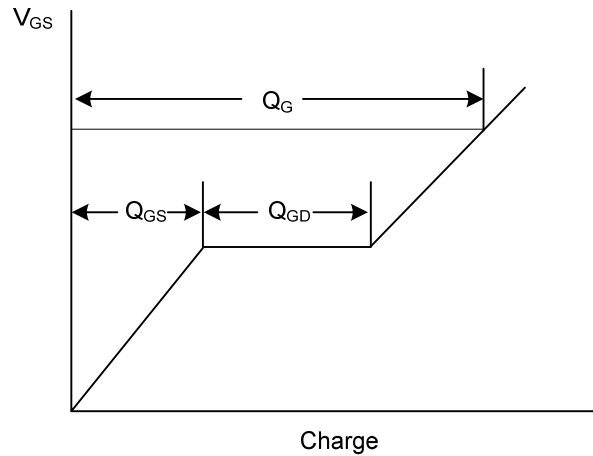
Switching Test Circuit



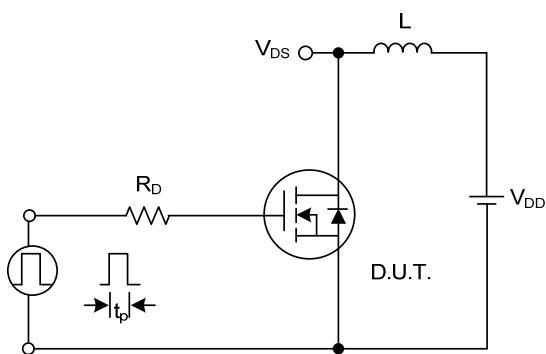
Switching Waveforms



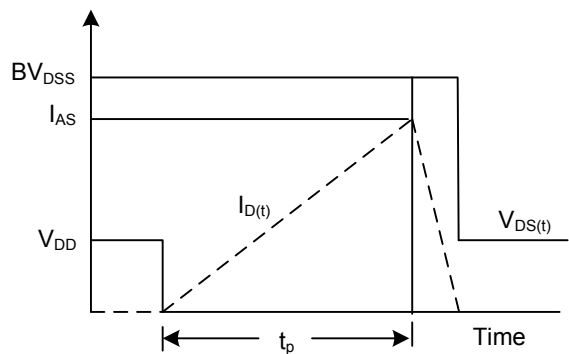
Gate Charge Test Circuit



Gate Charge Waveform

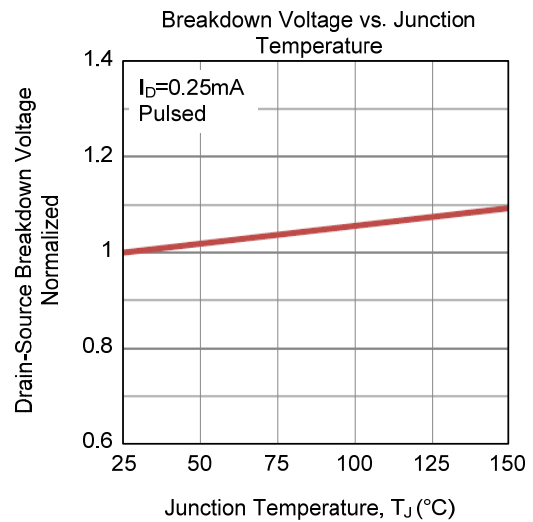
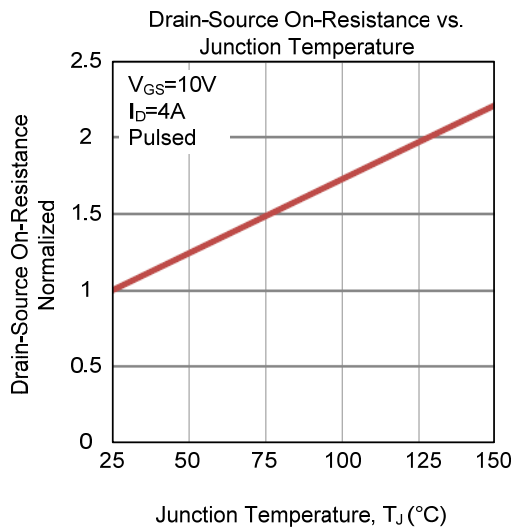
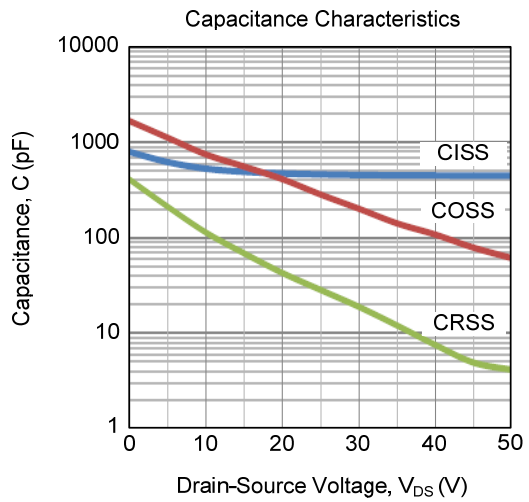
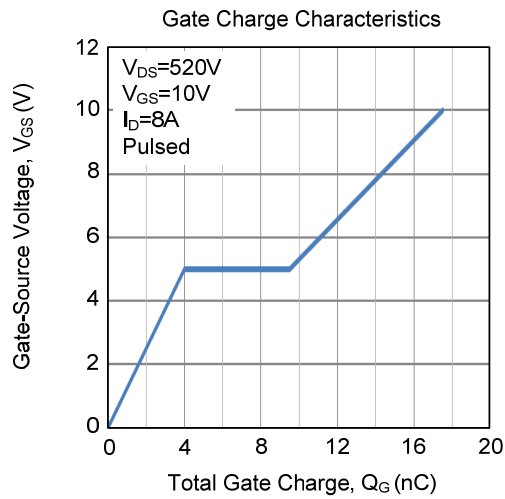
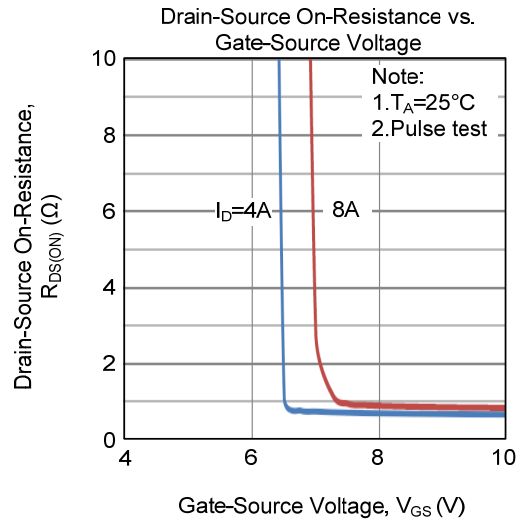
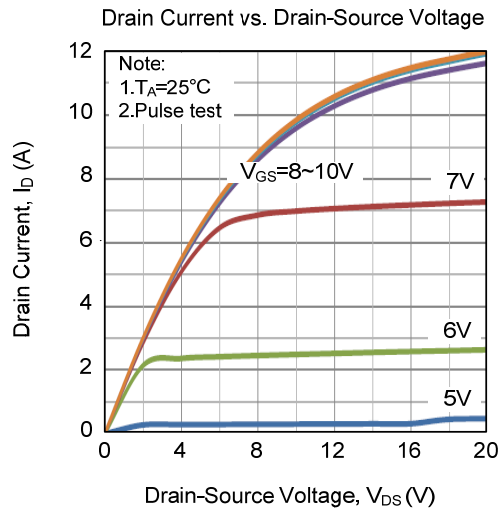


Unclamped Inductive Switching Test Circuit

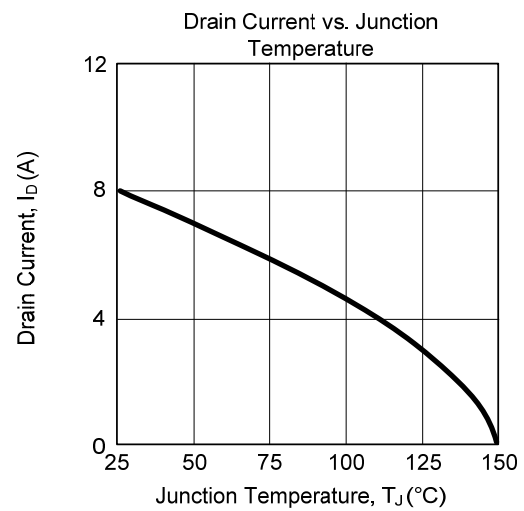
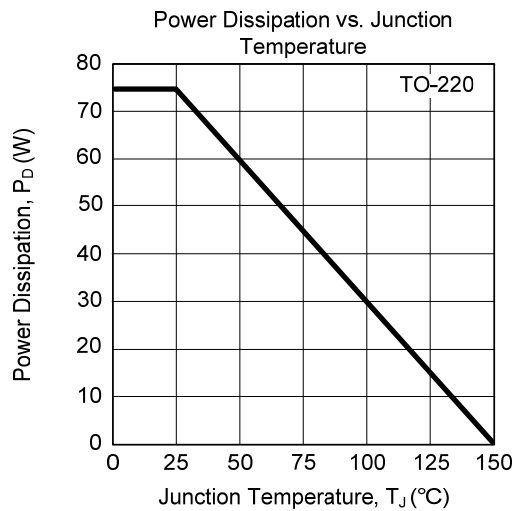
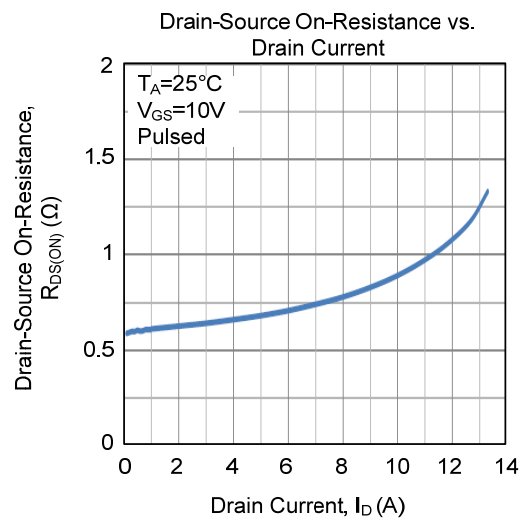
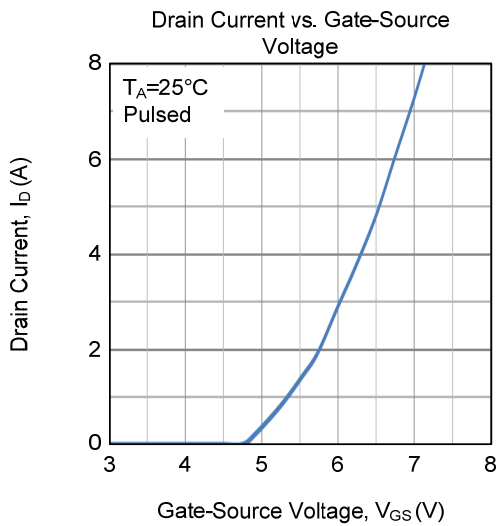
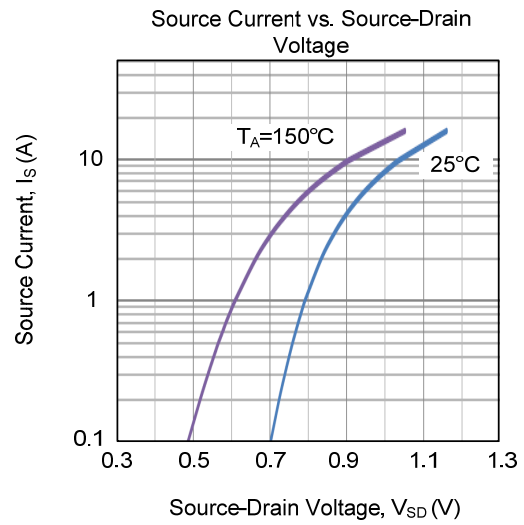
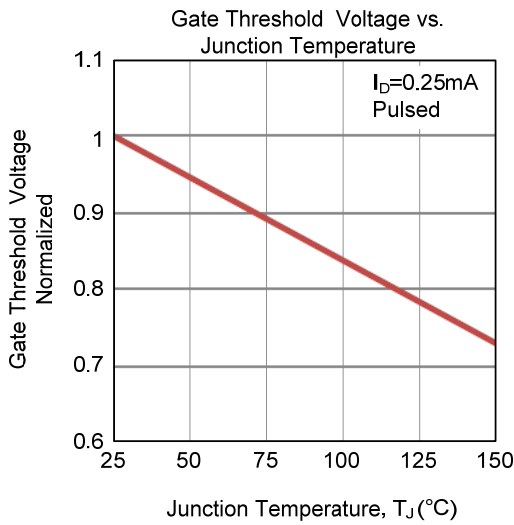


Unclamped Inductive Switching Waveforms

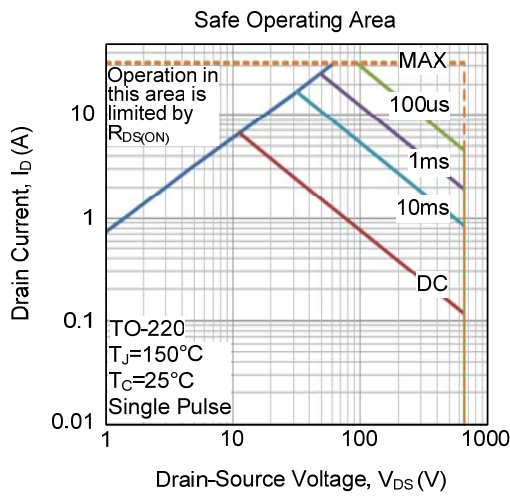
TYPICAL CHARACTERISTICS



■ TYPICAL CHARACTERISTICS (Cont.)



■ TYPICAL CHARACTERISTICS (Cont.)



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